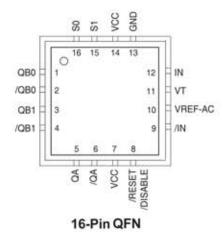
PACKAGE/ORDERING INFORMATION



Ordering Information⁽¹⁾

Part Number	Package Type	Operating Range	Package Marking	Lead Finish
SY89872UMG	QFN-16	Industrial	872U with Pb-Free bar line indicator	NiPdAu Pb-Free
SY89872UMGTR ⁽²⁾	QFN-16	Industrial	872U with Pb-Free bar line indicator	NiPdAu Pb-Free

Notes:

1. Contact factory for die availability. Dice are guaranteed at $T_A = 25^{\circ}C$, DC Electricals only.

2. Tape and Reel.

PIN DESCRIPTION

Pin Number	Pin Name	Pin Function
1, 2, 3, 4	QB0, /QB0 QB1, /QB1	Differential LVDS Compatible Outputs: Divide by 2, 4, 8, 16. Unused outputs must be terminated with 100ý across the pin (Q, /Q).
5,6	QA, /QA	Differential LVDS Compatible Undivided Output Clock.
7, 14	VCC	Positive Power Supply: Bypass with 0.1µF/0.01µF low ESR capacitors.
8	/RESET, /DISABLE	Output Reset and Output Enable/Disable: Internal 25ký pull-up. Input threshold is V _{CC} /2. Logic LOW will reset the divider select, and align Bank A and Bank B edges. In addition, when LOW, Bank A and Bank B will be disabled.
12, 9	IN, /IN	Differential Reference Input Clock: Internal 50ý termination resistors to V _T input. See "Input Interface Applications" section.
10	VREF-AC	Reference Voltage: Equal to V _{CC} -1.4V (approx.), and used for AC-coupled applications. Maximum sink/source current is 0.5mA. See "Input Interface Applications" section.
11	VT	Termination Center-Tap: For DC-coupled CML and LVDS inputs, leave this pin floating. See "Input Interface Applications" section.
13	GND	Ground.
15, 16	S1, S0	Select Pins: LVTTL/CMOS logic levels. Internal 25ký pull-up resistor. Logic HIGH if left unconnected (divided by 16 mode). S0 = LSB. Input threshold is V _{CC} /2.

TRUTH TABLE

/RESET /DISABLE	S1	S0	Bank A Output	Bank B Outputs
1	0	0	Input Clock	Input Clock +2
1	0	1	Input Clock	Input Clock +4
1	1	0	Input Clock	Input Clock +8
1	1	1	Input Clock	Input Clock +16
0	х	x	QA = Low, /QA = High ⁽¹⁾	QB0 = Low, $/$ QB0 = High ⁽²⁾ QB1 = Low, $/$ QB1 = High ⁽²⁾

Note 1. On the next negative transition of the input signal.

Note 2. Asynchronous reset/disable function. (See "Timing Diagram")

Absolute Maximum Ratings^(Note 1)

Supply Voltage (V _{CC})	0.5V to +6.0V
Input Voltage (VIN)	0.5V to V _{CC}
LVDS Output Current (IOUT)	
Input Current IN, /IN (IIN)	±50mA
VREF-AC Input Sink/Source Current (IVRE	F-AC),Note 3 . ±2mA
Lead Temperature (soldering, 20sec.)	
Storage Temperature (T _S)	65°C to +150°C

Operating Ratings^(Note 2)

Supply Voltage Range 2.375V t	o 2.625V
Ambient Temperature (T _A)40°C	to +85°C
Package Thermal Resistance	
QFN (0 _{JA})	
Still-Air	60°C/W
500lfpm	54°C/W
QFN (VJB), Note 4	
Junction-to-Board	32°C/W

Note 1. Permanent device damage may occur if absolute maximum ratings are exceeded. This is a stress rating only and functional operation is not implied at conditions other than those detailed in the operational sections of this data sheet. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Note 2. The datasheet limits are not guaranteed if the device is operated beyond the operating ratings.

Note 3. Due to the limited drive capability use for input of the same package only.

Note 4. Junction-to-board resistance assumes exposed pad is soldered (or equivalent) to the device's most negative potential on the PCB.

DC ELECTRICAL CHARACTERISTICS(Note 1, 2)

T_A= -40°C to +85°C; Unless otherwise stated.

Symbol	Parameter	Condition	Min	Тур	Max	Units
V _{CC}	Power Supply Voltage		2.375	2.5	2.625	V
lcc	Power Supply Current	No load, max. V _{CC}		75	110	mA
R _{IN}	Differential Input Resistance (IN-to-/IN)		90	100	110	ý
VIH	Input High Voltage IN, /IN	Note 3	0.1		V _{CC} +0.3	V
VIL	Input Low Voltage IN, /IN	Note 3	-0.3		V _{IH} -0.1	V
VIN	Input Voltage Swing	Notes 3, 4	0.1		Vcc	V
VDIFF_IN	Differential Input Voltage Swing	Notes 3, 4, 5	0.2			V
I _{IN}	Input Current IN, /IN	Note 3			45	mA
VREF-AC	Reference Voltage	Note 6	V _{CC} -1.525	V _{CC} -1.425	V _{CC} -1.325	V

Note 1. The circuit is designed to meet the DC specifications shown in the above table after thermal equilibrium has been established.

Note 2. Specification for packaged product only.

Note 3. Due to the internal termination (see "Input Buffer Structure" section) the input current depends on the applied voltages at IN, /IN and V_T inputs. Do not apply a combination of voltages that causes the input current to exceed the maximum limit!

Note 4. See "Timing Diagram" for VIN definition. VIN (max.) is specified when VT is floating.

Note 5. See Figures 1c and 1d for V_{DIFF} definition.

Note 6. Operating using V_{IN} is limited to AC-coupled PECL or CML applications only. Connect directly to V_T pin.

LVDS OUTPUTS DC ELECTRICAL CHARACTERISTICS(Note 1, 2)

	$V_{CC} = 2.5V \pm 5\%$; T ₄	= -40° C to $+85^{\circ}$ C; Unless otherwise stated.
--	--	--

Symbol	Parameter	Condition	Min	Тур	Max	Units
V _{OUT}	Output Voltage Swing	Note 5	250	350	450	mV
V _{OH}	Output High Voltage	Note 3			1.475	V
V _{OL}	Output Low Voltage	Note 3	0.925			V
V _{OCM}	Output Common Mode Voltage	Note 4	1.125		1.375	V
ΔV_{OCM}	Change in Common Mode Voltage		-50		50	mV

Note 1. The circuit is designed to meet the DC specifications shown in the above table after thermal equilibrium has been established.

Note 2. Specification for packaged product only.

Note 3. Measured as per Figure 1a, 100ý across Q and /Q outputs.

Note 4. Measured as per Figure 1b.

Note 5. See Figure 1c.

LVTTL/CMOS INPUTS DC ELECTRICAL CHARACTERISTICS(Note 1, 2)

Symbol	Parameter	Condition	Min	Тур	Max	Units
V _{IH}	Input HIGH Voltage		2.0	-	V _{CC}	V
V _{IL}	Input LOW Voltage		0	-	0.8	V
I _{IH}	Input HIGH Current		-125	-	20	μA
I _{IL}	Input LOW Current		-	-	-300	μA

Note 1. The circuit is designed to meet the DC specifications shown in the above table after thermal equilibrium has been established.

Note 2. Specification for packaged product only.

AC ELECTRICAL CHARACTERISTICS(Note 1, 2)

Symbol	Parameter	Condition	Min	Тур	Max	Units
f _{MAX}	Maximum Toggle Frequency	Output Swing: 2200mV	2			GHz
	Maximum Input Frequency	Note 3	3.2			GHz
t _{PD}	Differential Propagation Delay	Input Swing: <400mV	500	625	750	ps
	IN to Q	Input Swing: ž400mV	450	575	700	ps
t _{skew}	Within-Device Skew (differential) (QB0-to-QB1)	Note 4		7	15	ps
	Within-Device Skew (differential) (Bank A-to-Bank B)	Note 4		12	30	ps
	Part-to-Part Skew (differential)	Note 4			250	ps
t _{rr}	Reset Recovery Time	Note 5	600			ps
T _{jitter}	RMS Phase Jitter	Output = 622MHz Integration Range: 12kHz - 20MHz		265		fs
t _r , t _r	Rise / Fall Time (20% to 80%)		70	130	200	ps

 V_{CC} = 2.5V ±5%; T_A = -40°C to +85°C; Unless otherwise stated.

Note 1. Measured with 400mV input signal, 50% duty cycle. 100ý termination between Q and /Q, unless otherwise stated.

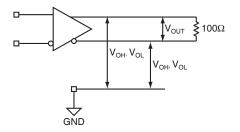
Note 2. Specification packaged product only.

Note 3. Bank A (pass-through) maximum frequency is limited by the output stage. Bank B (input-to-output +2, +4, +8, +16) can accept an input frequency >3GHz, while Bank A will be slew rate limited.

Note 4. Skew is measured between outputs under identical transitions.

Note 5. See "Timing Diagram."

LVDS OUTPUT



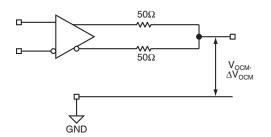


Figure 1a. LVDS Differential Measurement



DEFINITION OF SINGLE-ENDED AND DIFFERENTIAL SWING

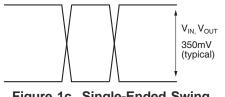


Figure 1c. Single-Ended Swing

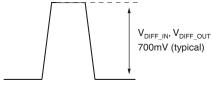
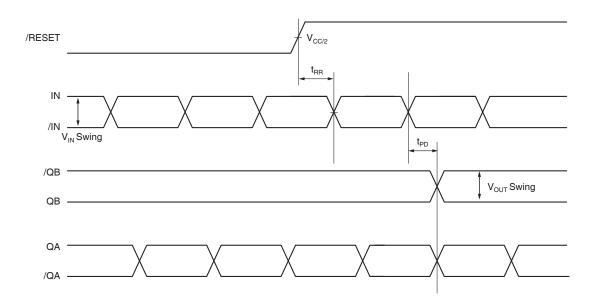


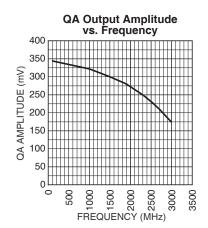
Figure 1d. Differential Swing

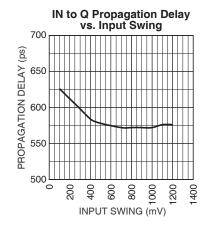
TIMING DIAGRAM

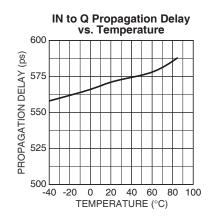


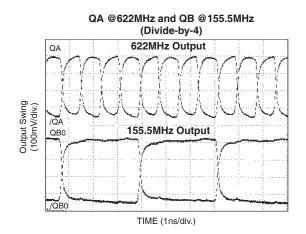
TYPICAL OPERATING CHARACTERISTICS

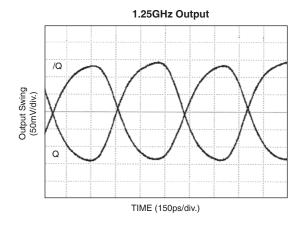
 V_{CC} = 2.5V, V_{IN} = 400mV, T_A = 25°C, unless otherwise stated.



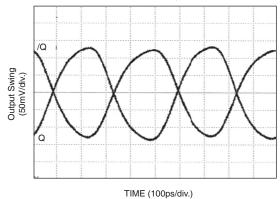






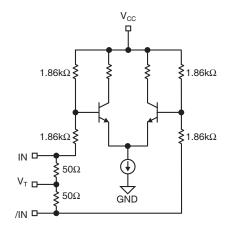


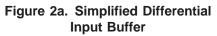
2GHz Output





INPUT BUFFER STRUCTURE





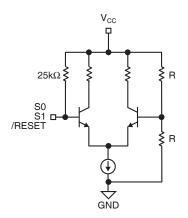
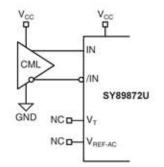
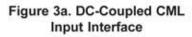


Figure 2b. Simplified TTL/CMOS Input Buffer

INPUT INTERFACE APPLICATIONS





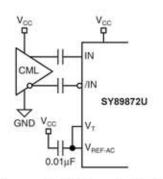


Figure 3b. AC-Coupled CML Input Interface

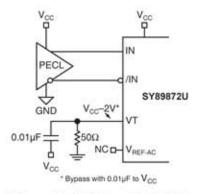


Figure 3c. DC-Coupled PECL Input Interface

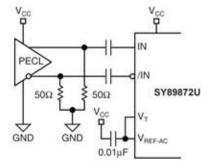


Figure 3d. AC-Coupled PECL Input Interface

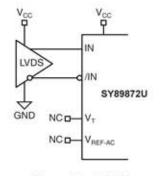


Figure 3e. LVDS Input Interface

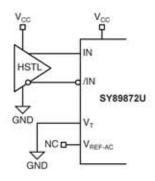
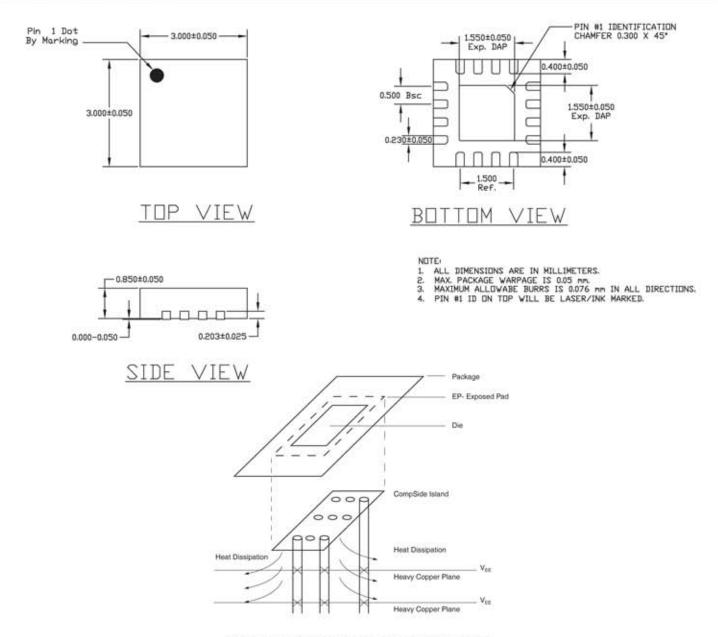


Figure 3f. HSTL Input Interface

RELATED PRODUCT AND SUPPORT DOCUMENTATION

Part Number	Function	Data Sheet Link
SY89871U	2.5GHz Any Diff. In-to-LVPECL Programmable Clock Divider/Fanout Buffer w/Internal Termination	http://www.micrel.com/product-info/products/sy89871u.shtml
SY89873L	3.3V, 2GHz Any Diff. In-to-LVDS Programmable Clock Divider/Fanout Buffer	http://www.micrel.com/product-info/products/sy89873I.shtml
HBW Solutions	New Products and Applications	http://www.micrel.com/product-info/products/solutions.shtml

16-PIN QFN (QFN-16)



PCB Thermal Consideration for 16-Pin QFN Package (Always solder, or equivalent, the exposed pad to the PCB)

Package Notes:

Note 1. Package meets Level 2 moisture sensitivity classification, and is shipped in dry-pack form. Note 2. Exposed pads must be soldered to a ground for proper thermal management.

MICREL, INC. 2180 FORTUNE DRIVE SAN JOSE, CA 95131 USA

TEL + 1 (408) 944-0800 FAX + 1 (408) 944-0970 WEB http://www.micrel.com

The information furnished by Micrel in this datasheet is believed to be accurate and reliable. However, no responsibility is assumed by Micrel for its use. Micrel reserves the right to change circuitry and specifications at any time without notification to the customer.

Micrel Products are not designed or authorized for use as components in life support appliances, devices or systems where malfunction of a product can reasonably be expected to result in personal injury. Life support devices or systems are devices or systems that (a) are intended for surgical implant into the body or (b) support or sustain life, and whose failure to perform can be reasonably expected to result in a significant injury to the user. A Purchaser's use or sale of Micrel Products for use in life support appliances, devices or systems is at Purchaser's own risk and Purchaser agrees to fully indemnify Micrel for any damages resulting from such use or sale.

© 2005 Micrel, Incorporated.

Downloaded from Arrow.com.